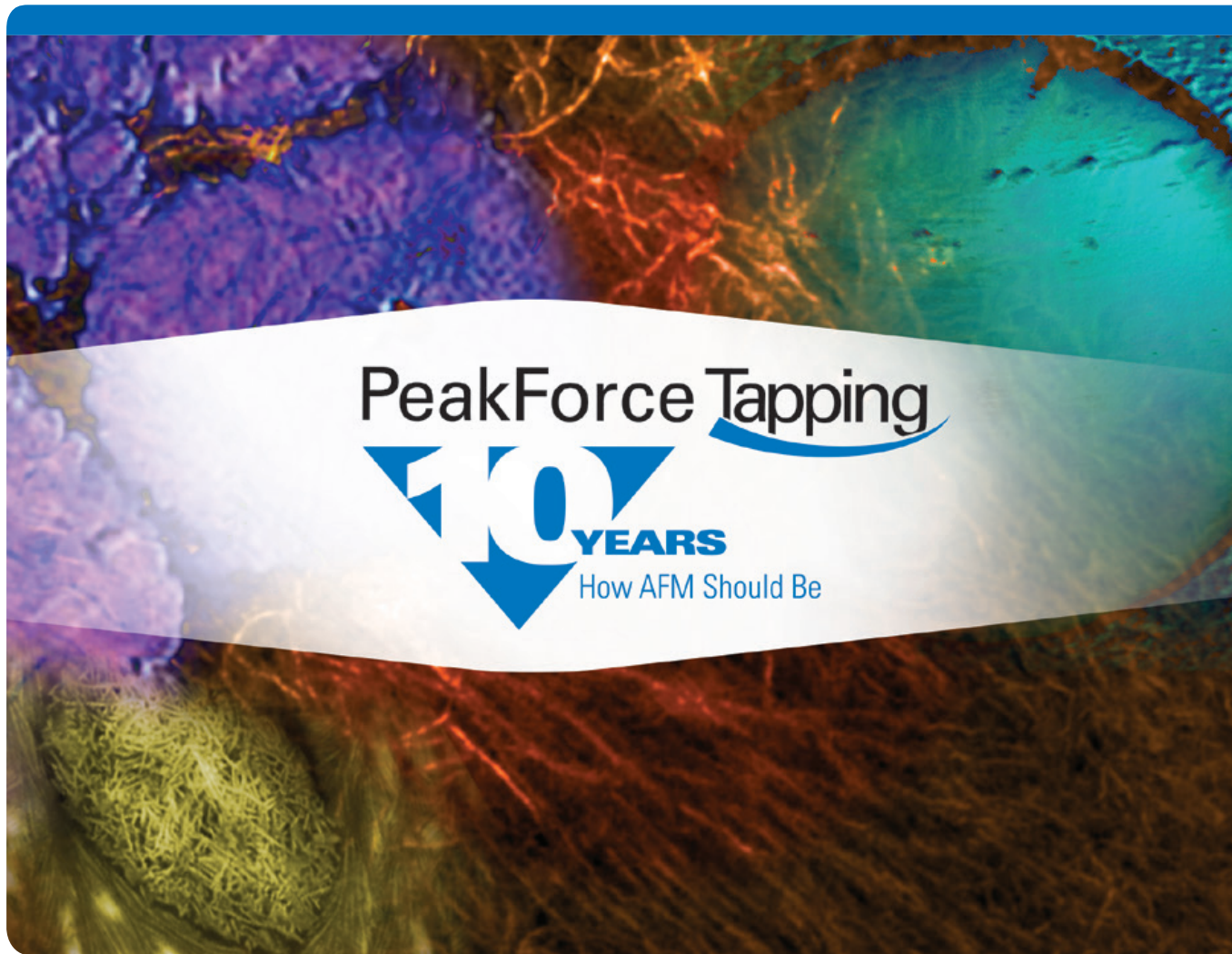




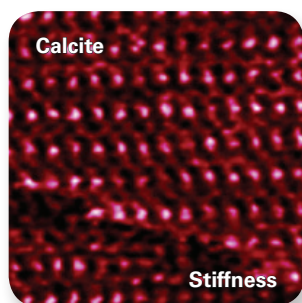
PeakForce Tapping

- Quantitative, Highest Resolution Imaging and Property Mapping

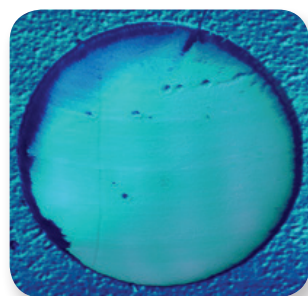
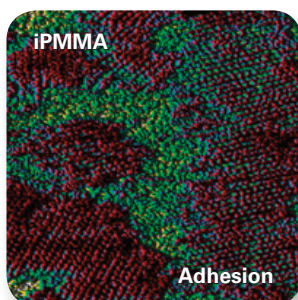
PeakForce Tapping

How AFM Should Be — for 10 Years and Counting

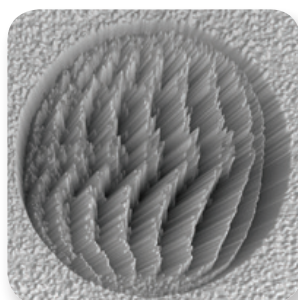
Bruker's exclusive PeakForce Tapping® has been the most significant scientific breakthrough in atomic force microscope (AFM) technology since the introduction of TappingMode™. It provides unprecedented high-resolution imaging, extends AFM measurements into a range of samples not previously accessed and uniquely enables simultaneous nanoscale property mapping.



Point defect resolution stiffness on calcite (15 nm image) and submolecular resolution adhesion on iPMMA (100 nm image).
Sample courtesy of T. Thurn-Albrecht, Martin-Luther-Universität Halle-Wittenberg.



Suspended graphene membrane imaged clearly in PeakForce Tapping (blue, adhesion on height), where TappingMode fails (grey).



Highest resolution imaging

PeakForce Tapping enables the researcher to precisely control probe-to-sample interaction enabling the lowest available imaging forces. This superior force control results in the most consistent, highest resolution AFM imaging for the widest range of sample types, from the softest biological samples to very hard materials.

Unique, quantitative results, whatever you measure

PeakForce Tapping's piconewton (pN) force sensitivity simultaneously and uniquely combines the highest resolution AFM imaging with quantitative, nanoscale electrical, mechanical, biological, and chemical property mapping, enabling researchers of all experience levels to make new discoveries.

Easy to use, making every user an AFM expert

PeakForce Tapping's direct and linear force control provides the user with unmatched AFM ease of use with ScanAsyst® image optimization software, and the low forces preserve the probe shape for longer life and more consistent imaging.



"PeakForce Tapping provided my lab with the force control and resolution necessary to produce ground-breaking ligand-receptor interaction maps using functionalized probes on live cells in a very time efficient and controlled way."

— Daniel Müller, ETH Zürich, Switzerland

● Enabling New Discoveries

In PeakForce Tapping, the probe periodically taps the sample and the pN-level interaction force is measured directly by the deflection of the cantilever. A real feedback loop (not force trigger) keeps the peak force down to 10 pN at actuation rates up to 8 kHz, in air and fluid.

PeakForce Tapping is ideal for both materials research and biological samples due to its unprecedented low imaging forces and ease of use. No cantilever tuning is necessary. The superior force control maintains tip and sample integrity, leading to consistently accurate and high-resolution measurements of even the smallest structures, from atomic defects to double helix DNA.

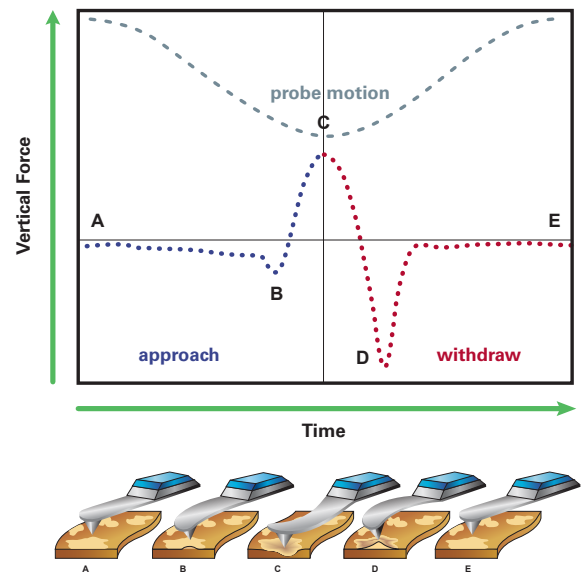
“Thanks to PeakForce QNM, we were able to rapidly obtain pertinent information on the mechanical properties of very soft and sticky polymer materials, such as bioadhesives or adaptive hydrogels, that other classical SPM techniques were not able to provide.”

– Philippe Leclère et. al., University of Mons (UMONS), Belgium

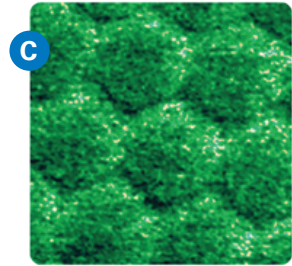
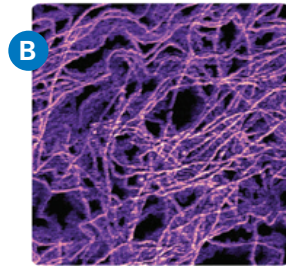
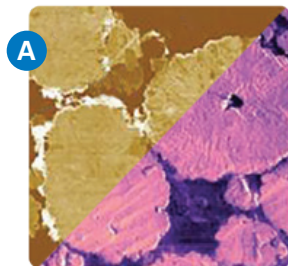


The adoption rate of PeakForce Tapping has surpassed even that of TappingMode, with over 4,000 publications in the ten years since its release. This includes over 2000 publications using PeakForce QNM and more than 400 using PeakForce electrical modes. That is more than one PeakForce Tapping article every day, for 10 years!

The greatest power of PeakForce Tapping technology, however, comes from its ability to simultaneously enable and enhance other correlative and quantitative mapping techniques. It provides new mechanical, electrical, and chemical information on previously inaccessible samples and delivers new possibilities spanning from soft matter to perovskites and energy research.



Three examples of data only available with PeakForce Tapping: (A) correlated electrical and mechanical mapping reveals inactive metal oxide grains in battery cathode; (B) measuring conductivity of individual P3HT nanowires not amenable to contact mode; and (C) nanoscale strain distribution in graphene on boron nitride. Image (C) courtesy of C. Woods, University of Manchester.



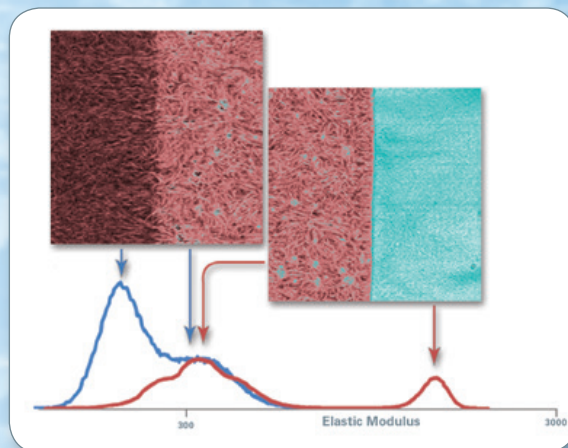
● Perfecting Nanomechanics on Materials

Quantitative at Highest Resolution

Utilizing PeakForce Tapping technology, PeakForce QNM® maps and distinguishes between nanomechanical properties—including modulus, adhesion, dissipation, and deformation—while simultaneously imaging sample topography at atomic scale resolution. Because it directly controls the peak normal force and minimizes lateral force on the probe, it is non-destructive to both tip and sample. Since force distance data is analyzed directly, there is no ambiguity regarding the source of image contrast, as often occurs in other techniques. The quantitative data produced can help identify components and their mixing at interfaces, as well as map mechanical properties at previously unattainable resolution.

PeakForce QNM provides:

- Highest resolution mapping of nanomechanical properties
- High-speed, most quantitative nanomechanical mapping
- Widest operating range for samples, from extremely soft materials (~1 kPa) to hard metals (100 GPa)



PeakForce QNM images of layered packaging showing fine structure and quantitative modulus values near phase boundaries of ULDPE, LDPE, and PS. Image size 4 μm .



More than 2000 publications cite PeakForce QNM data.

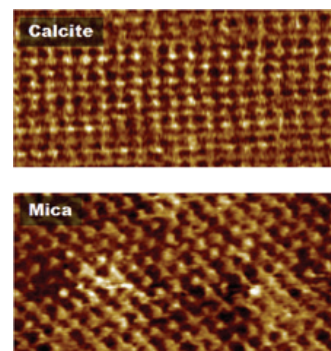
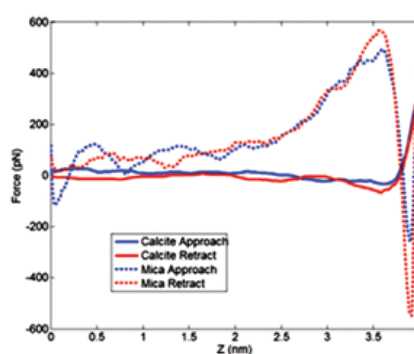
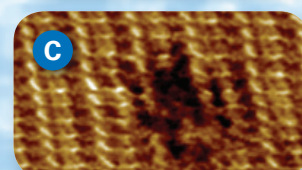
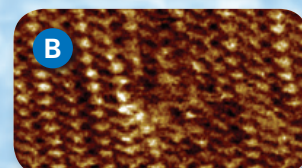
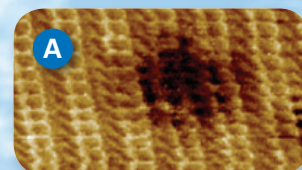
High-Sensitivity Nanomechanical Data at Every Pixel

Where PeakForce QNM analyzes each force curve in real time to generate material property maps, PeakForce Capture™ goes beyond the image to provide actual force curves at every pixel, in addition to the calculated property channels. When enabled, force curves from the PeakForce QNM image are saved alongside the standard image file. This allows direct calculations with NanoScope® analysis — with up to atomic defect resolution.

PeakForce Capture provides:

- Highest resolution force mapping
- Sensitivity to discover unexpected events not captured with other techniques
- User-specific models through data export features

PeakForce QNM reveals a molecular defect on a polydiacetylene crystal, in air. Individual molecules are resolved in height (A) as well as adhesion (B) and stiffness (C) maps, with a notable decrease in stiffness at the defect site. Image size 10 nm.



PeakForce Capture data cubes: Atomic resolution on calcite and mica (10 nm images) and individual force curves for every pixel show differences in tip-sample interaction.

● Achieving Full Nanoelectrical Characterization

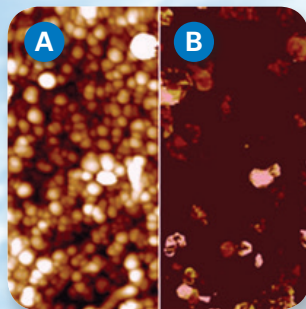
Current Mapping on the Most Fragile Samples

PeakForce TUNA™ is an ideal method for probing conductivity of fragile samples such as organic photovoltaics, conductive nanotubes, and nanoparticles. It overcomes the limitations of traditional contact-mode-based conductive AFM techniques by eliminating lateral forces and avoiding sample damage, thus enabling routine high-resolution current imaging.

Now users can benefit from both the full fA to μ A current range and directly correlated PeakForce QNM quantitative nanomechanical property imaging with one module. PeakForce TUNA can also be integrated with environmental control to regulate oxygen and water levels down to ppm for the most sensitive samples.

PeakForce TUNA offers:

- Highest resolution current mapping on the most fragile samples
- Unmatched repeatability and consistency in nanoelectrical measurements
- Correlated nanomechanical and nanoelectrical properties



PeakForce TUNA height (A) and current (B) maps of vertical carbon nanotubes, impossible with contact mode. Image size 1 μ m.



PeakForce TUNA current map reveals current paths in P3HT film. Image size 500 nm. Courtesy of P. Leclère, University of Mons, Belgium.



More than a 400 publications cite PeakForce electrical modes.

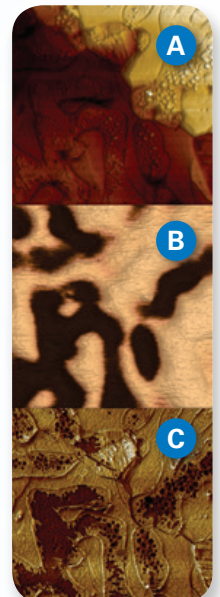
Accurate, High-Resolution Workfunction Mapping

PeakForce KPFM™ improves measurement performance over traditional Kelvin probe force microscopy techniques by providing the highest spatial resolution and most accurate measurements of surface potential. These improvements have been achieved with the combination of PeakForce Tapping, proprietary scan algorithms, and Bruker's in-house probe developments. Uniquely, PeakForce KPFM provides the most accurate and consistent measurements across different material types. It can be used with PeakForce QNM to deliver simultaneous, correlated topography, as well as electrical and mechanical property mapping on a wide range of samples. It also has overcome the ease-of-use issues of traditional KPFM techniques by operating in ScanAsyst mode, enabling the acquisition of expert-quality data by users of all experience levels.

PeakForce KPFM delivers:

- Most accurate, repeatable, and sensitive work function measurements
- Leading-edge spatial resolution combined with artifact-free potential contrast
- Correlated quantitative nanomechanical property mapping

PeakForce KPFM height (A), adhesion (B), and surface potential (C) images of Sn-Pb. The workfunction difference is accurately mapped, while nanoscale phase structure in the adhesion map is simultaneously revealed. Image size 4 μ m.



"With the combined application of PeakForce QNM and PeakForce TUNA we were uniquely able to determine the nanostructure and ionic conductivity distribution on humidity sensitive ionomers with unprecedented quality and resolution. For us, the versatility and flexibility with these modes opens the path for numerous explorations of materials for electrochemical energy applications."

— Renate Hiesgen,
University of Applied
Sciences Esslingen,
Germany

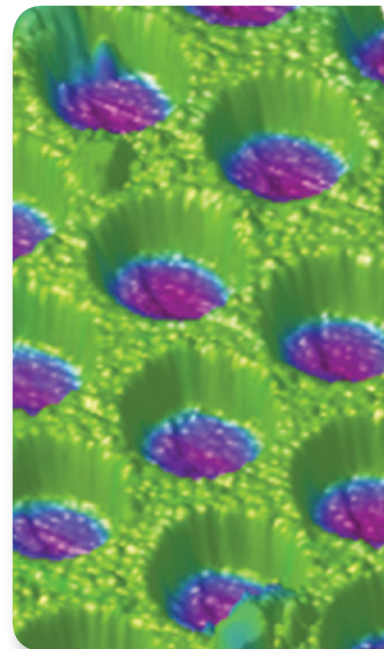
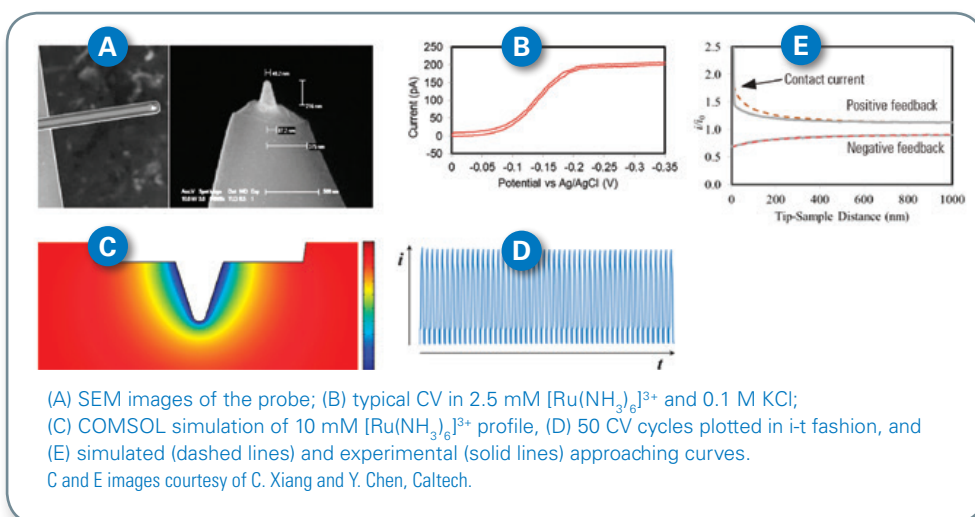
● Probing Local Electrochemistry

Sub-100nm Resolution in SECM

PeakForce SECM provides, for the first time, measurements of electrochemical activity with sub-100 nm resolution. This enables novel applications ranging from catalysis and corrosion to solar fuels and battery research. To make such difficult characterization a routine task, PeakForce SECM combines the piconewton force control of PeakForce Tapping with an exclusive probe solution. These PeakForce SECM probes are premounted for safe handling; batch fabricated; extensively tested; and highly optimized for high spatial resolution in SECM.

PeakForce SECM delivers:

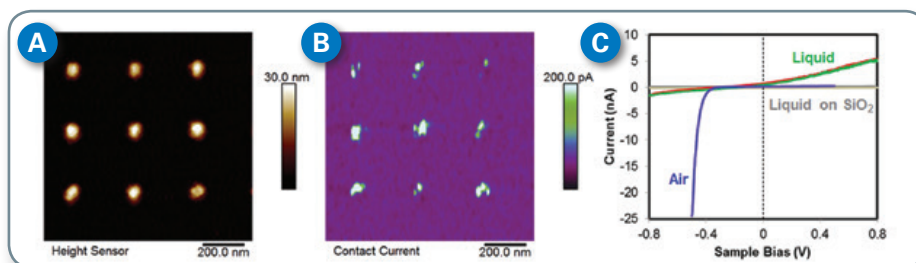
- Previously unobtainable electrochemical information with <100 nm spatial resolution
- Simultaneous electrochemical, electrical, and mechanical mapping in liquid
- Reliable, easy-to-use commercially available probes specifically designed for SECM



3D topography of a nanomesh electrode (Au-SiO_2) covered by EC current skin. Sample courtesy of C. Stelling and M. Retsch, University of Bayreuth.

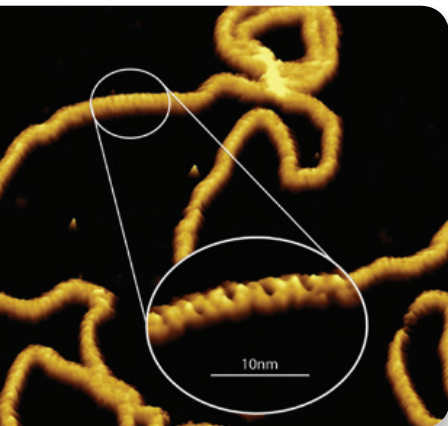
Previously Impossible Measurements of Conductivity in Liquid

PeakForce TUNA is the best method for high resolution conductivity measurements on fragile samples. Its advantage is even greater in liquid, where surfaces are often damaged more easily, as surface adsorbates become more mobile. Measuring conductivity in the presence of electrolyte requires an insulated probe where only the protruding apex is exposed, which is what the PeakForce SECM probe provides. Consequently the combination of PeakForce TUNA with the PeakForce SECM probe provides the first and only solution to in situ electrical characterization in the presence of highly conductive liquids for energy research, biocompatible devices, and many other applications.



PeakForce TUNA™ measurement with the SECM probe in liquid on an array of nanoelectrodes (125 nm diameter and 300 nm period): (A) topography; (B) contact current; and (C) current-voltage characteristics of nanoelectrodes in air and in an aqueous solution.

• Expanding Life Sciences Research



DNA double helix structure showing major and minor grooves, imaged with PeakForce Tapping.

Courtesy of B. Hoogenboom and A. Pyne, University College London.

From Molecular Recognition to Mechanobiology

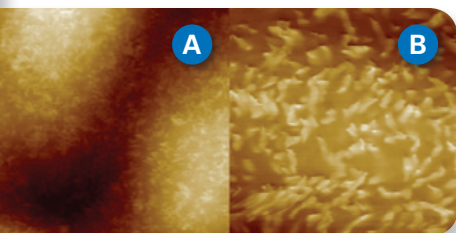
Overcoming limitations of conventional modes, PeakForce Tapping enables new research across a broad range of BioAFM areas, from single molecules to cells and tissues. It combines highest spatial resolution on biological structures with quantitative nanomechanics over the widest available frequency range.

In highest resolution molecular imaging, PeakForce Tapping images of individual biomolecules have revealed variations in the DNA double helix structure. In cell imaging, PeakForce Tapping has enabled the first and only images of microvilli on live cells.

PeakForce QNM has enabled high-impact work in high-resolution nanomechanical mapping on membranes, revealing stiffness variations in submolecular units. On live cells, PeakForce QNM-based recognition mapping has combined high spatial resolution, quantitative data, and optical microscopy to provide detailed insight into cell infection processes.

PeakForce QNM enables:

- Submolecular resolution mapping of mechanical, chemical and biological interactions
- High-speed, quantitative mechanical property and adhesion mapping of live cells
- Ease of use, making every user an AFM expert



First and only AFM images resolving individual microvilli on living MDCK cells. Image size 25 µm (A), 10 µm (B).

“It was previously impossible to resolve the finest structures of a live cell like microvilli, but now with the improved PeakForce Tapping on BioScope Resolve I can image them easily.”

– Hermann Schillers, University of Münster, Germany

Self-Optimizing Microscopy

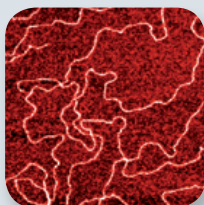
Intelligent Algorithms for Guaranteed High-Resolution Imaging

ScanAsyst is a PeakForce Tapping-based image optimization technique that enables every user to create the highest resolution AFM images using single-touch scanning. It eliminates the need to navigate complicated AFM interfaces and parameter settings, automating PeakForce Tapping so that extremely high-quality images can be produced by any user, regardless of experience level. “Intelligent” algorithms automatically and continuously monitor image quality and make appropriate parameter adjustments. The user simply selects a scan area and scan size for a sample, in air or fluid, essentially providing a turnkey solution for AFM imaging.

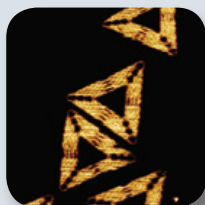
ScanAsyst enables:

- Easiest, consistent measurement of a wide range of samples for material research
- Single-button, repeatable roughness measurements for wafer applications
- Easiest, most stable high-resolution imaging of cells and molecules

DNA imaged using ScanAsyst. Image size 1 µm.



Triangle DNA origami structure imaged in fluid with ScanAsyst. Image size 300 nm. Sample courtesy of M. Endo and H. Sugiyama, Kyoto University.



ScanAsyst

See the Difference Peakforce Tapping Can Make

We welcome you to visit one of our many application labs worldwide to see for yourself how PeakForce Tapping modes work on your samples. Our application scientists will be pleased to work with you to define how best to solve your scientific and applications challenges.

PeakForce Tapping Applications

	ScanAsyst	PeakForce QNM	PeakForce Capture	PeakForce TUNA	PeakForce KPFM	PeakForce SECM	Invent Your Own
Characterization 2D materials, perovskites, and other novel nanostructured materials	●	●		●	●		PeakForce PFM
Composition mapping and nanomechanics of multiphase polymeric and composite materials	●	●	●	●	●		PeakForce Contact Res
Energy storage: In situ lithium ion battery anode, cathode, and SEI layer studies	●	●		●		●	
Other energy research: Operando studies of fuel cells, solar fuels, organic photovoltaics	●			●	●	●	
Local electrochemical activity and conductivity in liquid	●			●		●	
Molecular bio-imaging, including DNA, proteins, and membranes in liquid	●	●	●				
In situ live and fixed cell imaging, including recognition mapping and cell mechanics as function of disease states	●	●	●				
Semiconductor device characterization and failure analysis	●	●		●	●		PeakForce SCM; PeakForce SSRM
Analysis and classification of defects on industrial samples	●	●			●		
Roughness and deep trench measurements	●						

PeakForce Tapping Specifications

Typical imaging force	~10 pN
Minimum force setpoint	<0 pN (below free deflection)
Demonstrated spatial resolution	Atomic defect resolution in topography and stiffness
Actuation rate	125 Hz to 8 kHz, sine wave
Feedback	PI loop (not force trigger)
Force control	Automatically synchronized to peak force, direct, linear
Nanomechanical channels	Modulus (DMT, Sneddon), adhesion, deformation, dissipation, and peak force in real time (PeakForce QNM); Full force curve for each pixel (PeakForce Capture); Hertzian, Sneddon, Cone-Sphere, and JKR models offline
Conductivity measurement	<100 fA noise; >10 kHz bandwidth, no lateral forces (PeakForce TUNA); Current measurement in liquid (PeakForce SECM)
Workfunction mapping	AM-KPFM and FM-KPFM, main or lift line, with nanomechanical channels and ScanAsyst auto-optimization
Self-optimization	Linear feedback control auto-optimization (ScanAsyst), does not require prior sample knowledge

● Bruker Nano Surfaces Division

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Background image:
 Adhesion of iPMMA
 showing submolecular
 resolution. Sample courtesy of
 T. Thurn-Albrecht, Martin-Luther-
 Universitaet Halle-Wittenberg.